

Notice of References Cited	Application/Control No. 10/822,505	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Walter L. Lindsay, Jr.	Art Unit 2812	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,524,915	02-2003	Kim et al.	438/267
*	B	US-6,482,700	11-2002	Chen et al.	438/267
*	C	US-6,730,565	05-2004	Cho et al.	438/266
*	D	US-6,855,602	02-2005	Chang et al.	438/264
*	E	US-6,136,710	10-2000	Quek et al.	438/691
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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